


<b>Search Notes</b>  	<b>Application/Control No.</b>  10807390	<b>Applicant(s)/Patent Under Reexamination</b>  OZAWA ET AL.
	<b>Examiner</b>  Hung, Yubin	<b>Art Unit</b>  2624

SEARCHED			
Class	Subclass	Date	Examiner
382	166, 176, 182, 232, 233, 240, 292, 299	9/3/08	YH
358	426.12, 462	9/3/08	YH
375	240.19, 240.29	9/3/08	YH
708	203	9/3/08	YH

SEARCH NOTES		
Search Notes	Date	Examiner
EAST Text search (USPGPUB, USPAT, EPO, JPO, DERWENT, IBM-TDB)	9/3/08	YH
Inventor and assignee search (EAST, eDAN)	9/3/08	YH
ACM	9/3/08	YH
IEEE Xplore	9/3/08	YH
SPIE	9/3/08	YH

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
382,	166.233.240	9/3/08	YH
358	426.12,462	9/3/08	YH
375	240.19	9/3/08	YH

	/YUBIN HUNG/ Primary Examiner.Art Unit 2624
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